

The Half-Life of I^{131}

H. H. SELIGER, L. CAVALLO, AND S. V. CULPEPPER
National Bureau of Standards, Washington, D. C.

(Received January 2, 1953)

An accurate determination of the half-life of I^{131} gives the value $8.07_6 \pm 0.02_2$ days.

VALUES have been reported for the I^{131} half-life, ranging from 8.0 days^{1,2} to 8.14 days.³ The low values can be explained in part as being due to the instability of I^{131} sources prepared by evaporation.⁴ The high values can be explained on the basis of the 12-day metastable state of Xe^{131} to which I^{131} decays in approximately 1 percent of its disintegrations. If the source is such that the 12-day Xe^{131} isomeric state accumulates, and if the geometry is such that it is possible for the x- and γ -rays or conversion electrons of Xe^{131} to be detected, the measured half-life of the mixture will be greater than that of I^{131} alone.

Sreb³ used a sandwiched, powdered I^{131} source directly below a 1.4-mg/cm² G-M counter window, and Kurie, to whom Sreb refers as having obtained 8.16 days in 1946, prior to the knowledge of the isomeric

state of xenon, also used a sandwiched source; in this case directly below a 0.0002-in. aluminum ionization chamber window. In both cases, therefore, it is logical to assume that the decay of Xe^{131} was observed in addition to I^{131} .

With these factors in mind, the half-life of I^{131} has been redetermined with a Lauritsen electroscop by γ -ray comparison with radium and has been found to be $8.07_6 \pm 0.02_2$ days. The I^{131} was glass-sealed and the Xe^{131} radiation was completely attenuated by absorbing cylinders.

Independent determinations were made on three different samples of I^{131} received from the Oak Ridge National Laboratory from which the National Bureau of Standards I^{131} solution standards were also prepared and calibrated for semi-annual distribution.

The half-lives and standard deviations calculated by least squares are given in Table I.

The I^{131} sources were in the form of a solution of NaI in a wax-sealed, ground glass stoppered, 5-ml Pyrex volumetric flask and the Ra source was a 50-microgram solution standard in a 5-ml glass flame-sealed ampoule. The three determinations consisted of more than 1200 individual measurements which were made over periods of from 4 to 5 half-lives. The time-dependent variable was the ratio of the I^{131} drift rate to the Ra drift rate. It was found that the electroscop must remain fully charged at all times when not in use, to prevent insulator charging difficulties.

The authors thank Dr. Sreb and Dr. Kurie for discussions concerning their experimental arrangements.

TABLE I.

Determination	Absorber cylinder thickness	Half-life (days)
1 March-April 1952	5-mm Al	$8.08_9 \pm 0.01_4$
2 June-July 1952	5-mm Al, 2.5-mm Pb	$8.06_8 \pm 0.01_0$
3 Aug.-Sept. 1952	5-mm Al, 5.9-mm Pb	$8.08_3 \pm 0.02_6$

¹ J. J. Livingood and G. T. Seaborg, *Phys. Rev.* **54**, 775 (1938).

² S. Katcoff *et al.*, *Radiochemical Studies: The Fission Products* (McGraw-Hill Book Company, Inc., New York, 1951), Paper No. 143, National Nuclear Energy Series, Plutonium Project Record, Vol. 9, Div. IV.

³ J. H. Sreb, *Phys. Rev.* **81**, 643 (1951).

⁴ W. K. Sinclair and E. W. Emery, *Brit. J. Radiol.* **23**, 576 (1950).